

By Fax TO: (703) 872-9306



Sheet 1 of 1										Atty. Docket No. 4293		Serial No.: 10/017,983		
SEVENTH LIST OF REFERENCES CITED BY APPLICANT (REVISED FORM PTO-1449) DATED: <u>June 16, 2004</u>										Applicant: Masaaki HARASAWA et al.				
										U.S. Filing Date: December 13, 2001		Art Unit: 2839		
U. S. PATENT DOCUMENTS														
*EXAMINER INITIAL		DOCUMENT NO.							DATE	NAME	Cl.	Sub- Cl.	File Date	
FOREIGN PATENT DOCUMENTS														
		DOCUMENT NO.							DATE	COUNTRY	Cl.	Sub- Cl.	Trans. Yes No	
MCB	AG2		55	-	9	0	1	9	01/1980	Japan (Utility Model)	-	-	partial trans.	
MCE	AH2	1-	1	6	8	9	7	0	11/1989	Japan (Utility Model)	-	-	partial trans.	
MCE	AI2	4	-	7	2	4	8	8	06/1992	Japan (Utility Model)	-	-	partial trans.	
MCE	AJ2	09	3	0	6	5	7	6	11/1997	Japan	-	-	Abst.+ partial trans.	
OTHER DOCUMENTS														
EXAMINER <i>Michael Z...</i>										DATE CONSIDERED 3/28/05				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

Sheet 1 of 1

EIGHTH

LIST OF REFERENCES CITED BY
APPLICANT(REVISED FORM PTO-1449)
DATED: July 19, 2004Atty. Docket
No. 4293Serial No.:
10/017,983

Applicant: Masaaki HARASAWA et al.

U.S. Filing Date:
December 13, 2001Art Unit:
2839

U. S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	File Date
				-	-	-

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.							DATE	COUNTRY	Cl.	Sub- Cl.	Trans.	
													Yes	No
MCT	AK2	57	-	1	2	6	7	1	1982	Japan (Utility Model)	-	-	partial transla- tion	
MCT	AL2	1-	1	4	2	1	6	7	09/1989	Japan (Utility Model)	-	-	partial transla- tion	
MCT	AM2	08-	0	2	2	8	7	1	01/1996	Japan	-	-	Abst.+ partial transla- tion	
MCT	AN2	2002	1	8	4	4	8	9	06/2002	Japan	-	-	Abst.+ partial transla- tion	
MCT	AC	2001	3	0	7	7	9	9	11/2001	Japan	-	-	Abst.+ partial transla- tion	

OTHER DOCUMENTS

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EXAMINER

Michael C. Zand

DATE CONSIDERED

3/28/05

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Sheet <u>1</u> of <u>1</u> NINTH LIST OF REFERENCES CITED BY APPLICANT (REVISED FORM PTO-1449) DATED: <u>September 2, 2004</u>										Atty. Docket No. 4293		Serial No.: 10/017,983	
										Applicant: Masaaki HARASAWA et al.			
										U.S. Filing Date: December 13, 2001		Art Unit: 2839	
U. S. PATENT DOCUMENTS													
*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	Fil. Date							
MLZ	AO2 4 5 5 8 2 7 0	12/1985	Liautaud et al.	320	-2	-							
	AP2 5 2 7 1 7 4 0	12/1993	Endo et al.	439	637	-							
	AQ2 5 4 5 8 5 0 2	10/1995	Joly	439	397	-							
	AR2 6 0 9 5 8 5 5	08/2000	Iwata et al.	439	553	-							
7	AS2 6 1 2 6 4 5 8	10/2000	Gregory, II et al.	439	76.2	-							
FOREIGN PATENT DOCUMENTS													
DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans.								
					Yes	No							
OTHER DOCUMENTS													
EXAMINER <i>Michael C. Zand</i>							DATE CONSIDERED <i>3/28/05</i>						
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Sheet 1 of 1 TENTH IDS LIST OF REFERENCES CITED BY APPLICANT (FORM PTO-1449) DATED: January 26, 2005				Atty. Docket No. 4293		Serial No.: 10/017,983	
Applicant: Masaaki HARASAWA et al.							
U.S. Filing Date: December 13, 2001						Art Unit: 2839	
U. S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	Fil. Date	
MCE	AT2	5,456,617	10/1995	Chishina et al.	439	513	-
MCE	AU2	5,897,402	04/1999	Sasai et al.	439	752	-
FOREIGN PATENT DOCUMENTS							
DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans.		
AV2	10-340750	12/1998	Japan	-	-	Abstract + Translation	
AW2	1177675	04/1998	China	-	-	*AU2 *AX2	
AX2	O 822 616	02/1998	Europe	-	-	English	
OTHER DOCUMENTS							
EXAMINER <i>Richard C. Zando</i>				DATE CONSIDERED 3/28/05			
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Sheet 1 of 1 ELEVENTH IDS LIST OF REFERENCES CITED BY APPLICANT (FORM PTO-1449) DATED: March 18, 2005				Atty. Docket No. 4293		Serial No.: 10/017,983	
				Applicant: Masaaki HARASAWA et al.			
				U.S. Filing Date: December 13, 2001		Art Unit: 2839	
U. S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	File Date
MGE	AY2	6,099,356	08/2000	Hwang	439	660	-
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans. Yes
OTHER DOCUMENTS							
EXAMINER Michael J. Zundels		DATE CONSIDERED 3/28/05					
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Sheet 1 of 1 TWELFTH IDS LIST OF REFERENCES CITED BY APPLICANT (FORM PTO-1449) DATED: April 5, 2005				Atty. Docket No. 4293		Serial No.: 10/017,983	
Applicant: Masaaki HARASAWA et al.							
U.S. Filing Date: December 13, 2001						Art Unit: 2839	
U. S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	Cl.	Sub- Cl.	Fil. Date	
MCE	AE2	4,209,217	06/1980	Gudaitis et al.	439	372	
	AA3	4,295,009	10/1981	Weidler	179	110A	
	AB3	5,231,659	07/1993	Abraham et al.	379	433	
	AC3	5,484,295	01/1996	Mowry et al.	439	66	
	AD3	5,746,607	05/1998	Bricaud et al.	439	66	
D	AE3	6,022,224	02/2000	Peters	439	66	
FOREIGN PATENT DOCUMENTS							
DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub- Cl.	Trans.		
					Yes	No	
MCE	AF3	2,497,007	06/1982	France		x	
OTHER DOCUMENTS							
EXAMINER <i>Michael C. Zando</i>				DATE CONSIDERED <i>4/12/05</i>			
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